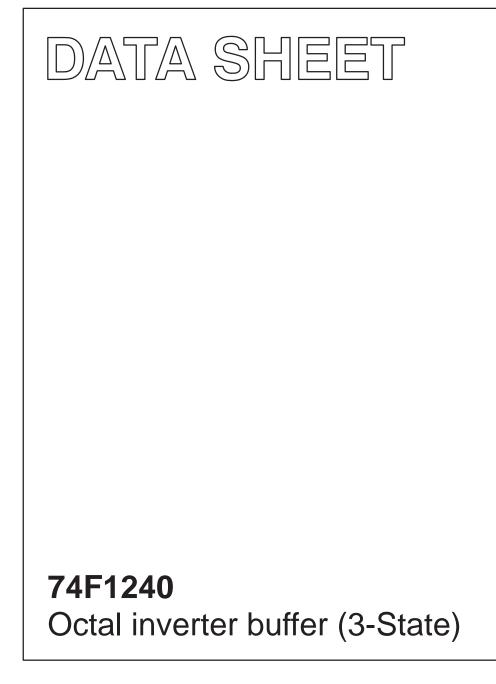
# INTEGRATED CIRCUITS



Product specification Supercedes data of 1999 Jan 08 IC15 Data Handbook 2000 Jun 30



74F1240

#### **FEATURES**

- High impedance NPN base inputs for reduced loading (20µA in High and Low states)
- Low power, light loading
- Functional pin-for-pin equivalent of 74F240
- 1/30th the bus loading of 74F240
- Provides ideal interface and increase fan-out of MOS microprocessors
- Octal bus interface
- 3-State buffer outputs sink 64mA
- 15mA source current

#### DESCRIPTION

The 74F1240 is an octal buffer that is ideal for driving bus lines or buffer memory address registers. The outputs are capable of sinking 64mA and sourcing up to 15mA, producing very good capacitive drive characteristics. The device features two Output Enables,  $\overline{OEa}$  and  $\overline{OEb}$ , each controlling four of the 3-State outputs.

#### INPUT AND OUTPUT LOADING AND FAN OUT TABLE

PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
lan, Ibn	Data inputs	1.0/0.033	20μΑ/20μΑ
OEa, OEb	Output enable inputs (active Low)	1.0/0.033	20μΑ/20μΑ
Yan, Ybn	Data outputs (74F1240)	750/106.7	15mA/64mA

**NOTE:** One (1.0) FAST unit load is defined as:  $20\mu$ A in the High state and 0.6mA in the Low state.

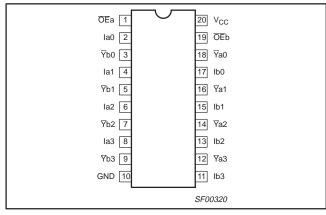
# TYPETYPICAL<br/>PROPAGATION<br/>DELAYTYPICAL<br/>SUPPLY CURRENT<br/>(TOTAL)74F12403.5ns40mA

#### **ORDERING INFORMATION**

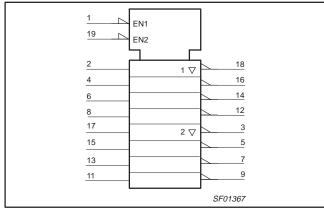
DESCRIPTION	$\begin{array}{l} \text{COMMERCIAL RANGE} \\ \text{V}_{CC} = 5\text{V} \pm 10\%, \\ \text{T}_{amb} = 0^{\circ}\text{C to} + 70^{\circ}\text{C} \end{array}$	DRAWING NUMBER
20-pin plastic DIP	N74F1240N	SOT146-1
20-pin plastic SOL	N74F1240D	SOT163-1

## 74F1240

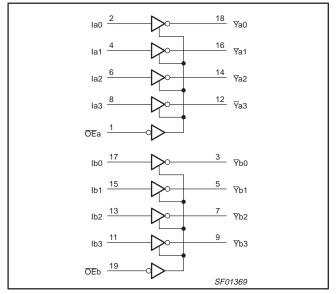
#### **PIN CONFIGURATION**



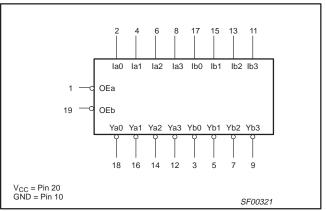
#### **IEC/IEEE SYMBOL**



#### LOGIC DIAGRAM



#### LOGIC SYMBOL



#### **FUNCTION TABLE**

	INP	UTS		OUTF	PUTS
OEa	la	OEb	lb	Ya	Yb
L	L	L	L	Н	Н
L	Н	L	Н	L	L
Н	Х	Н	Х	Z	Z

H = High voltage level L = Low voltage level

X = Don't care Z = High impedance "off" state

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#### **ABSOLUTE MAXIMUM RATINGS**

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V <sub>CC</sub>	Supply voltage	-0.5 to +7.0	V
V <sub>IN</sub>	Input voltage	-0.5 to +7.0	V
I <sub>IN</sub>	Input current	-30 to +5	mA
V <sub>OUT</sub>	Voltage applied to output in High output state	–0.5 to $V_{CC}$	V
I <sub>OUT</sub>	Current applied to output in Low output state	128	mA
T <sub>amb</sub>	Operating free-air temperature range	0 to +70	°C
T <sub>stg</sub>	Storage temperature range	-65 to +150	°C

#### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	DADAMETED		LINUT		
STMBOL	PARAMETER	MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage	4.5	5.0	5.5	V
V <sub>IH</sub>	High-level input voltage	2.0			V
V <sub>IL</sub>	Low-level input voltage			0.8	V
I <sub>IK</sub>	Input clamp current			-18	mA
I <sub>OH</sub>	High-level output current			-15	mA
I <sub>OL</sub>	Low-level output current			64	mA
T <sub>amb</sub>	Operating free-air temperature range	0		+70	°C

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#### DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

CVMDO:	DADAMETER									
SYMBOL	PARAMETER		TEST CONDITIONS <sup>1</sup>				TYP <sup>2</sup> MAX			
				1	±10% V <sub>CC</sub>	2.4			V	
V			V <sub>CC</sub> = MIN V <sub>II</sub> = MAX	I <sub>OH</sub> = -3mA	±5% V <sub>CC</sub>	2.7	3.3		V	
V <sub>OH</sub>	High-level output voltage		$V_{IH} = MIN$	I <sub>OH</sub> = -15mA	±10% V <sub>CC</sub>	2.0			V	
				$I_{OH} = -15111A$	$\pm 5\% V_{CC}$	2.0			V	
M			$V_{CC} = MIN$ $V_{II} = MAX$	I <sub>OL</sub> = 48mA	±10% V <sub>CC</sub>		0.38	0.55	V	
V <sub>OL</sub>	Low-level output voltage		$V_{IL} = MIAX$ $V_{IH} = MIN$	I <sub>OL</sub> = 64mA	±5% V <sub>CC</sub>		0.42	0.55	V	
V <sub>IK</sub>	Input clamp voltage	$V_{CC} = MIN, I_I = I_{IK}$				-0.73	-1.2	V		
lı	Input current at maximum input voltage		$V_{CC} = 0.0V, V_{I} = 7.0V$					100	μA	
I <sub>IH</sub>	High-level input current		$V_{CC} = MAX,$	$V_{I} = 2.7 V$				20	μA	
IIL	Low-level input current		V <sub>CC</sub> = MAX,	$V_{ } = 0.5V$				-20	μA	
I <sub>OZH</sub>	Off-state output current, High-level voltage applied		V <sub>CC</sub> = MAX,	$V_{0} = 2.7 V$				50	μA	
I <sub>OZL</sub>	Off-state output current, Low-level voltage applied		V <sub>CC</sub> = MAX,	$V_{O} = 0.5V$				-50	μΑ	
I <sub>OS</sub>	Short-circuit output current <sup>3</sup>		$V_{CC} = MAX$			-100		-225	mA	
		I <sub>CCH</sub>					22	30	mA	
I <sub>CC</sub>	Supply current (total)	I <sub>CCL</sub>	V <sub>CC</sub> = MAX				58	75	mA	
		I <sub>CCZ</sub>					44	58	mA	

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type. 2. All typical values are at  $V_{CC} = 5V$ ,  $T_{amb} = 25^{\circ}C$ . 3. Not more than one output should be shorted at a time. For testing  $I_{OS}$ , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I<sub>OS</sub> tests should be performed last.

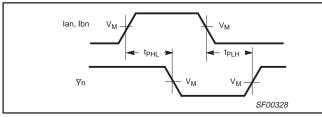
#### **AC ELECTRICAL CHARACTERISTICS**

					LIM	ITS		
SYMBOL	PARAMETER	TEST CONDITION	V	<sub>amb</sub> = +25 / <sub>CC</sub> = +5.0 50pF, R <sub>L</sub> =	V	V <sub>CC</sub> = +5	C to +70°C .0V ± 10% R <sub>L</sub> = 500Ω	UNIT
			MIN	TYP	MAX	MIN	MAX	
t <sub>PLH</sub>	Propagation delay	Waveform 1	3.0	4.5	6.5	2.5	7.5	ns
t <sub>PHL</sub>	Ian, Ibn, to Yn		1.5	2.5	4.5	1.5	5.0	ns
t <sub>PZH</sub>	Output Enable time	Waveform 3	3.0	5.5	7.5	3.0	8.0	ns
t <sub>PZL</sub>	to High or Low level	Waveform 4	4.0	7.0	9.0	4.0	9.5	ns
t <sub>PHZ</sub>	Output Disable time	Waveform 3	2.0	4.0	6.0	2.0	6.5	ns
t <sub>PLZ</sub>	to High or Low level	Waveform 4	2.0	4.0	5.5	2.0	6.0	ns

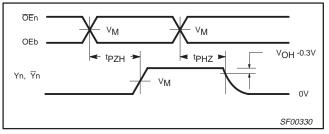
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#### **AC WAVEFORMS**

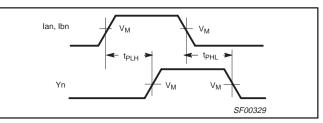
For all waveforms,  $V_M = 1.5V$ .



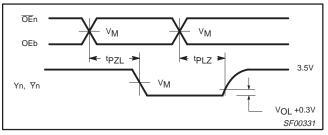
Waveform 1. For Inverting Outputs

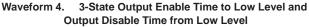


Waveform 3. 3-State Output Enable Time to High Level and Output Disable Time from High Level

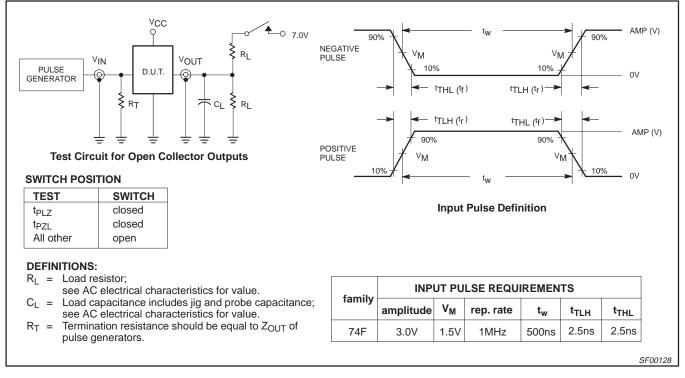


Waveform 2. For Non-inverting Outputs



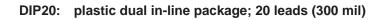


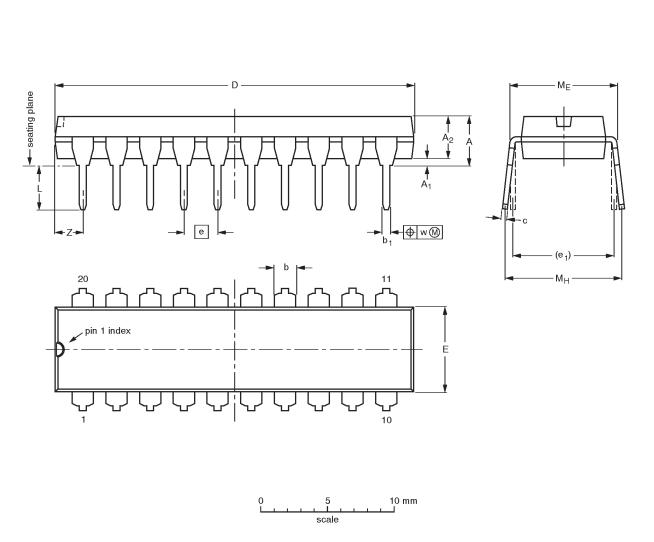
#### TEST CIRCUIT AND WAVEFORMS



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#### Product specification





#### DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	с	D <sup>(1)</sup>	Е <sup>(1)</sup>	e	e <sub>1</sub>	L	M <sub>E</sub>	M <sub>H</sub>	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

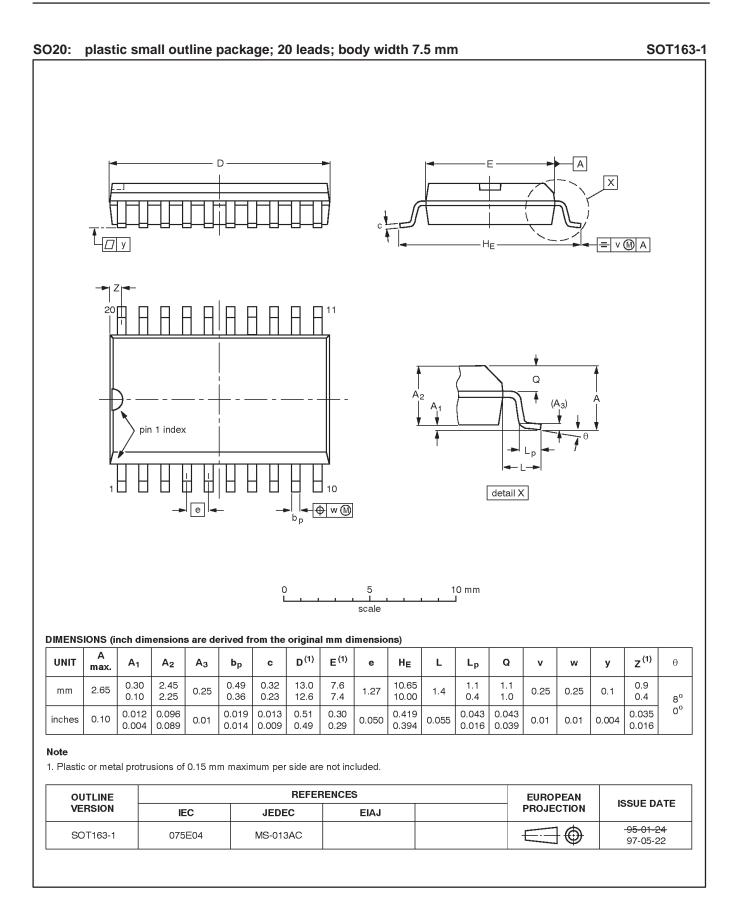
#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFEF	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT146-1			SC603			<del>-92-11-17-</del> 95-05-24

SOT146-1

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NOTES

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#### Data sheet status

Data sheet status	Product status	Definition <sup>[1]</sup>
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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> Date of release: 06-00 9397-750 07279

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